

Reduction of Secondary Electron Yield For e-Cloud Mitigation by Laser Ablation Surface Engineering (LASE)

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Oleg B. Malyshev, Sihui Wang (PhD student)

N.Sykes (Micronanics)

Dr. Philippe Goudket (ASTeC)

Lewis Gurran (ASTeC)





Evaluation of LASE for particle accelerator application

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- SEY



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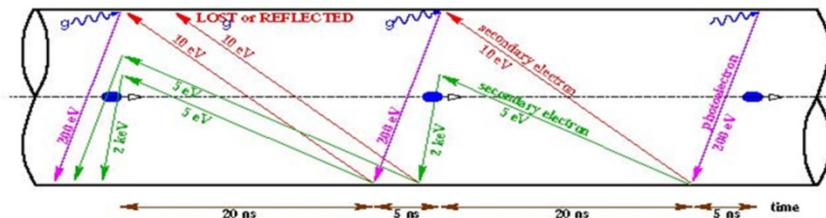
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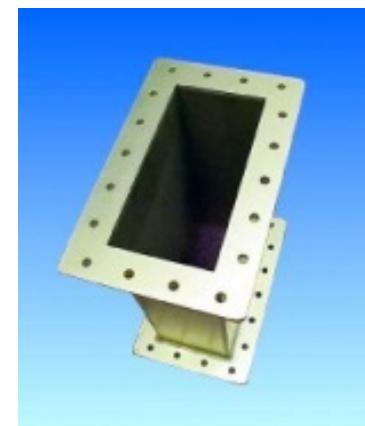
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- Surface Chemistry



Main Goal

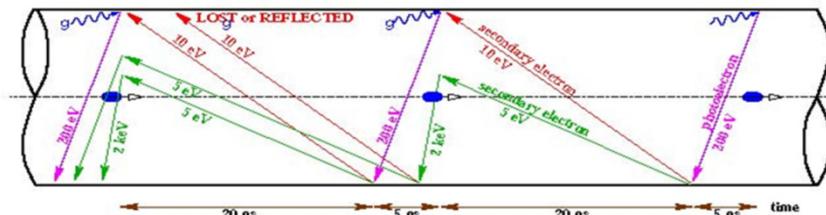


Courtesy to
F. Ruggero





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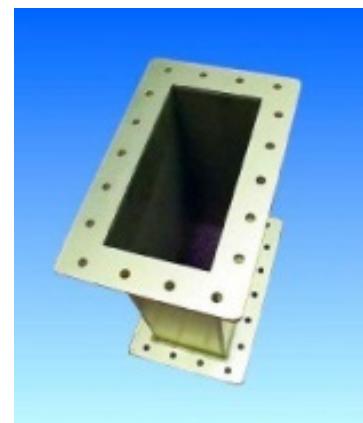


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1. Mitigation of beam-induced electron cloud built-up in a particle accelerator beam chamber due to photo- and secondary electron emission

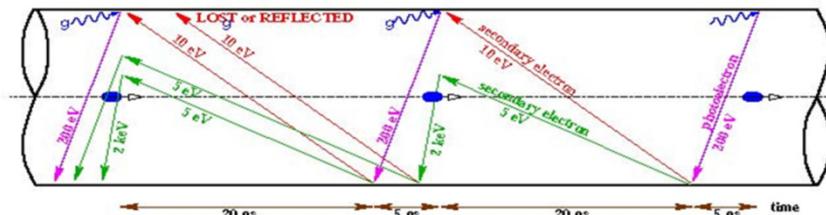
To reduce:

- beam instability, beam losses, emittance growth, reduction in beam life time





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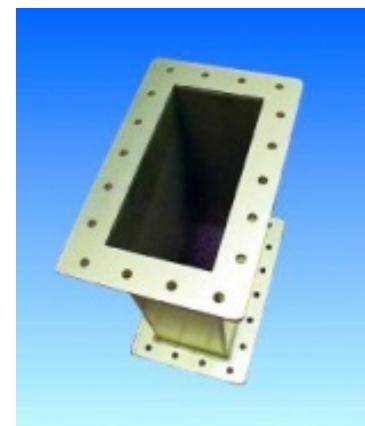
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To reduce:

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2. Mitigation of Multipacting in RF wave guide and space-related high power RF hardware.





Existing Mitigation method

- **By Passive means:**

- **Advantages**

- **Disadvantages**

- Stainless steel as received
- Stainless steel conditioned lab 5E-2 C/mm² e-
- △ Stainless Steel conditioned SPS
- DCCMS
- DCMS dipole's field
- ▲ DCMS permanent magnets
- ◆ DCHCS
- PECVD
- HOPG (Graphite)

Existing Mitigation method

- **By Passive means:**

- Low SEY Material (Cladding)
- Low SEY coating(single/multiple step)
- Grooved Surfaces (coated /uncoated)
- Special shape of vacuum Chamber

An antichamber allows reducing PEY

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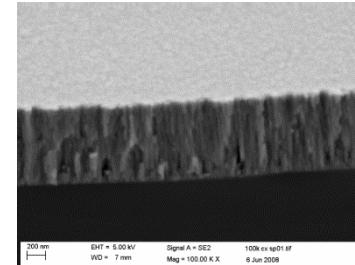
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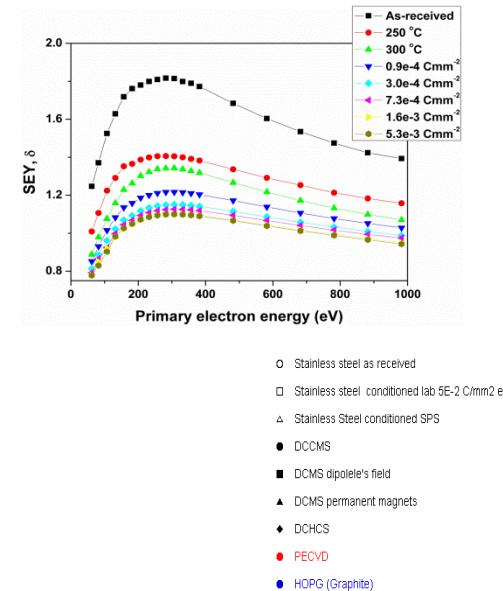
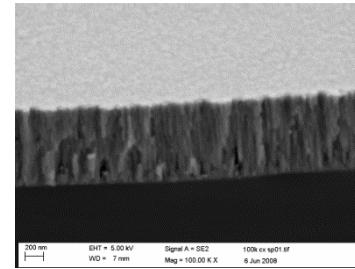
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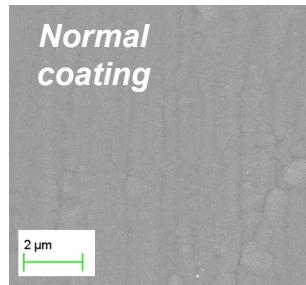
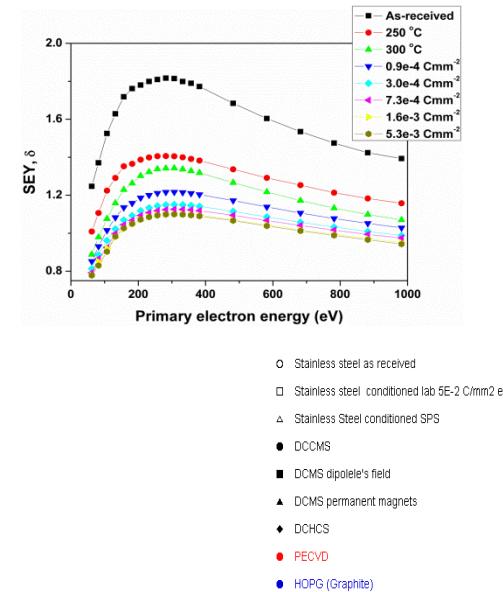
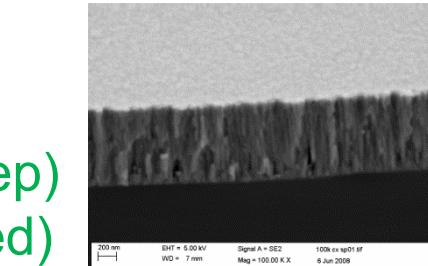
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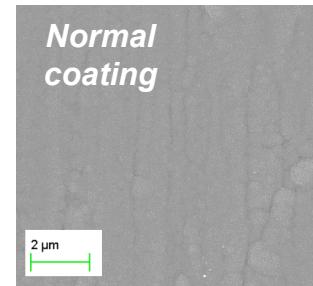
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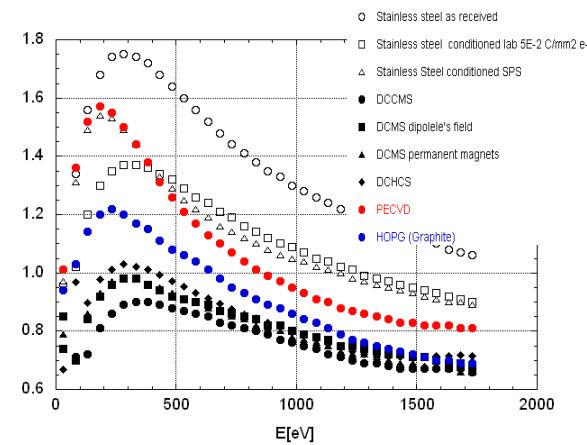
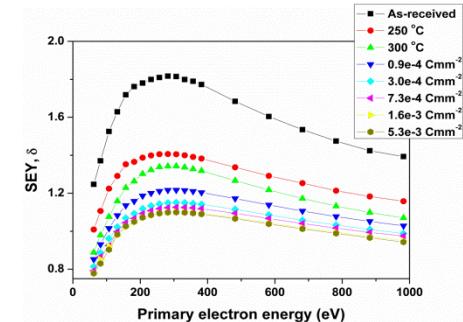
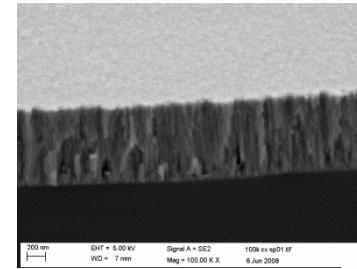
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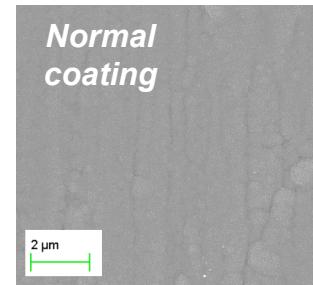
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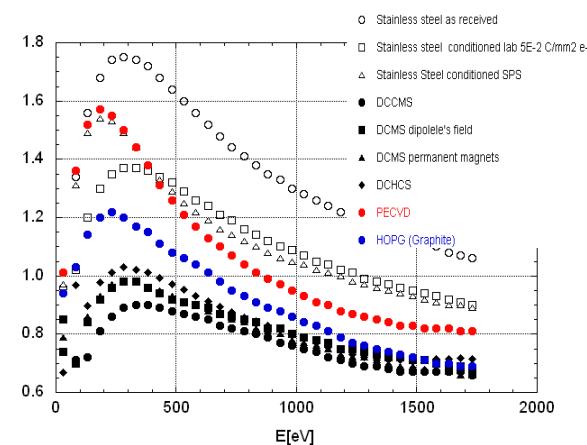
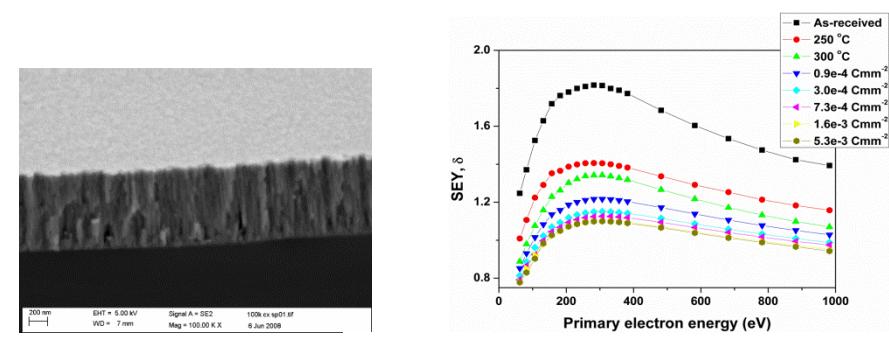
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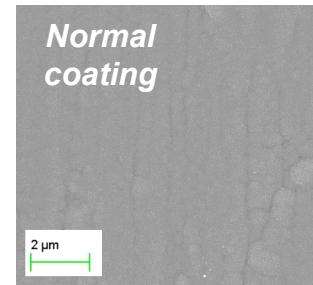
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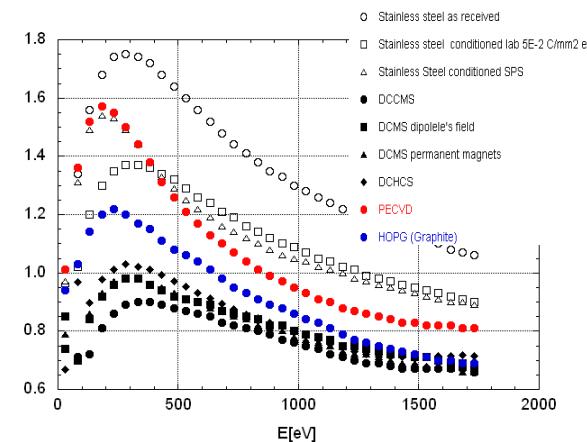
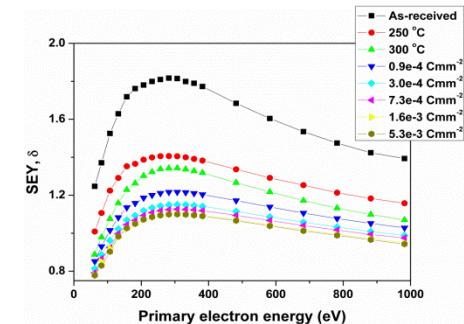
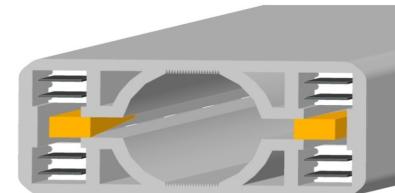
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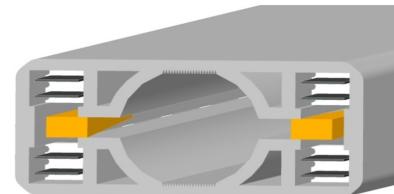
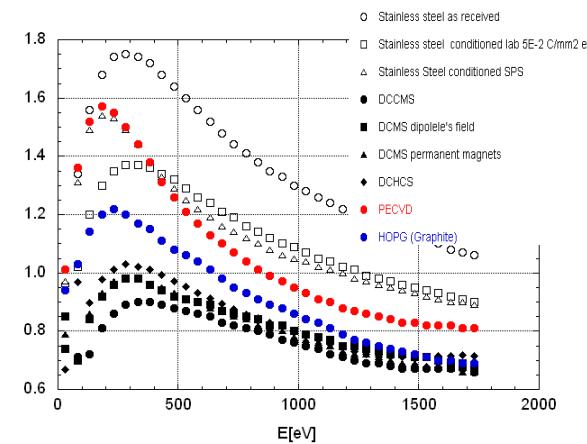
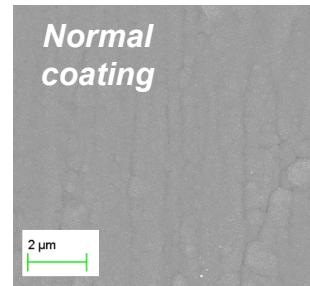
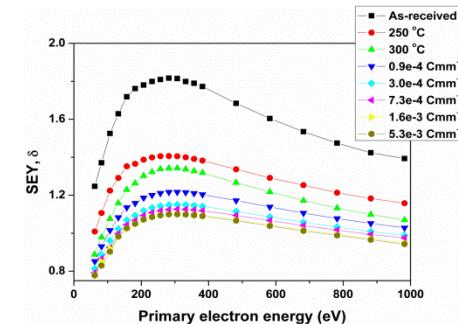
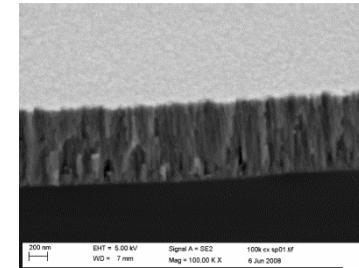
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- No Controllers,
- No power supplies,
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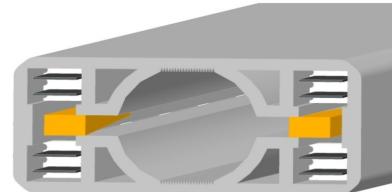
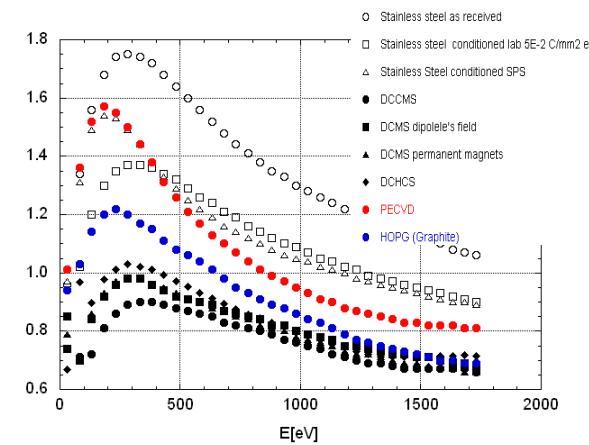
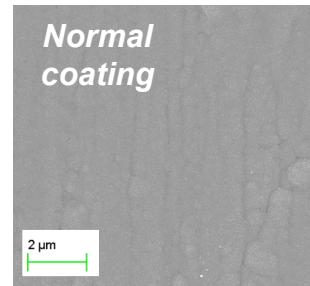
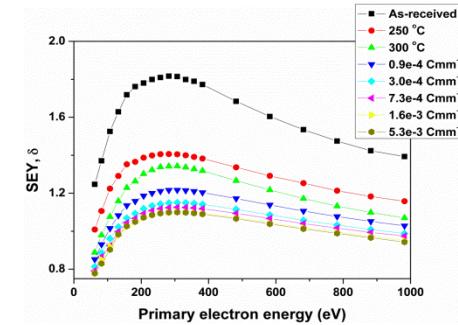
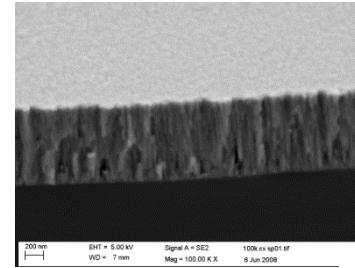
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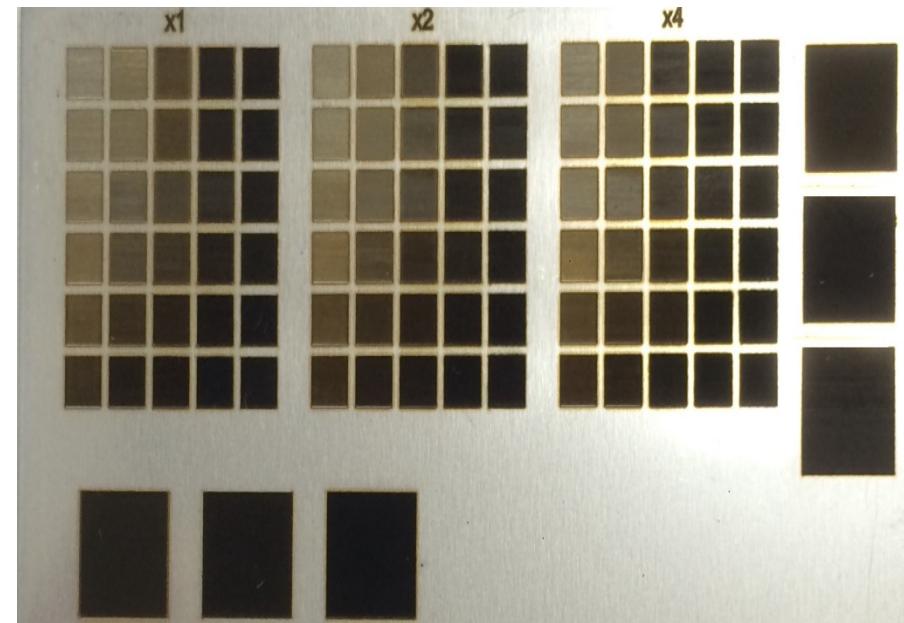
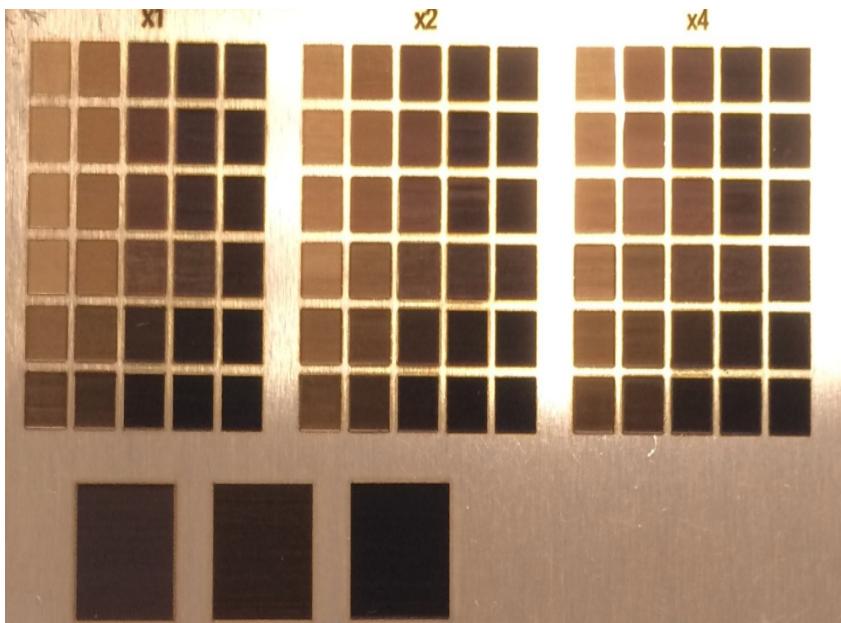
- In-vacuum deposition
- Difficult to apply on existing facilities
- Durations of surface treatments
- Cost





Introducing a new technology

- Recent discovery of ASTeC:
- Laser treatment of metals in air or noble gas atmosphere





Parameters involved in Micromachining



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- 1) Laser beam parameters:

- Average power
- Pulsed energy
- Beam profile
- Pulse duration
- Repetition rate,
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- Scan velocity
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•4) Process Parameters:

- Micromachining environment
- Gas pressure
- Temperature of the sample
- Mobility of sample relative to beam



Advantages Over Other method



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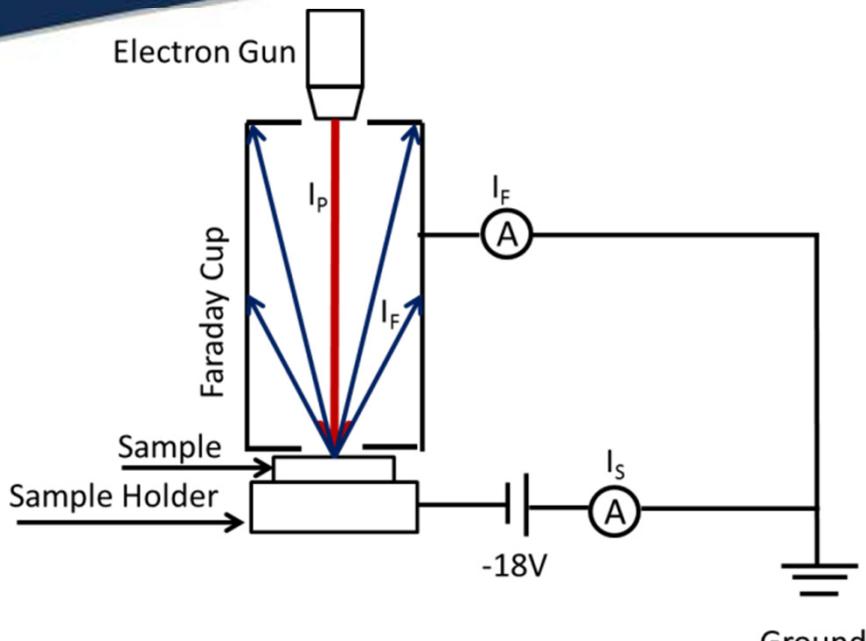


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- It is possible to lase in many different environments, such as gases, liquids, or in a vacuum.



SEY Measurements

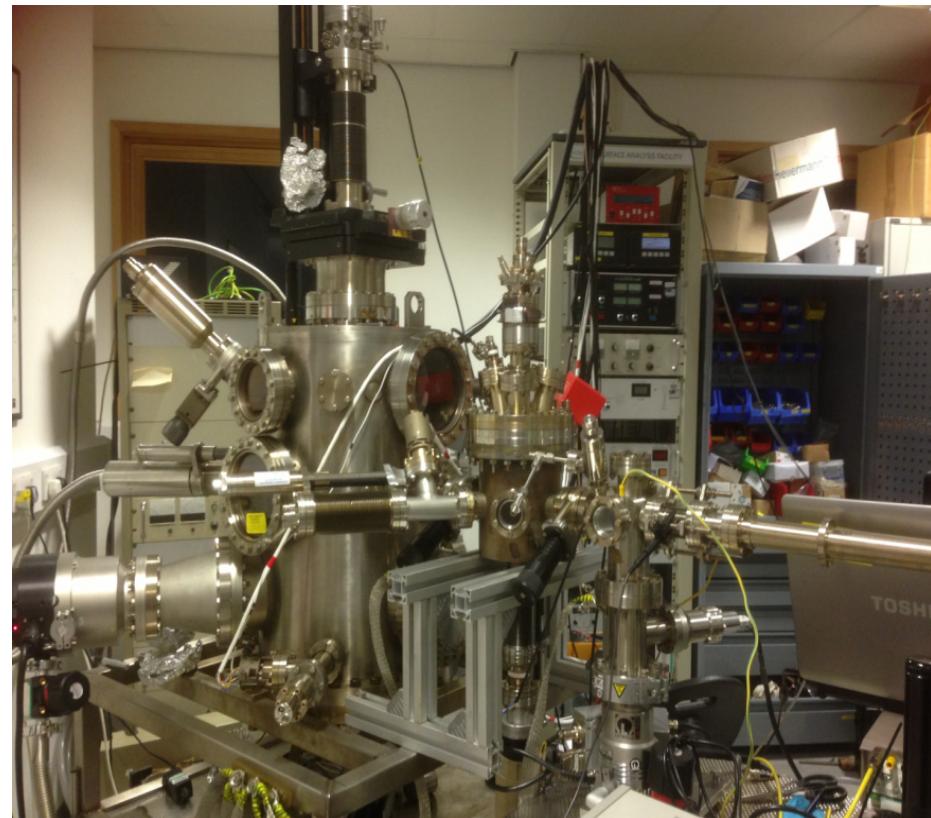


$$\delta = \frac{I_F}{I_P} = \frac{I_F}{I_F + I_S}$$

I_P is the primary beam current

I_F is the secondary electron current including elastic and inelastic processes, measured on the Faraday cup

I_S is the currents on the sample

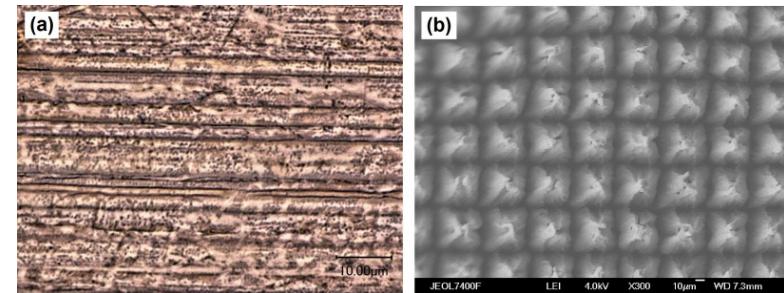
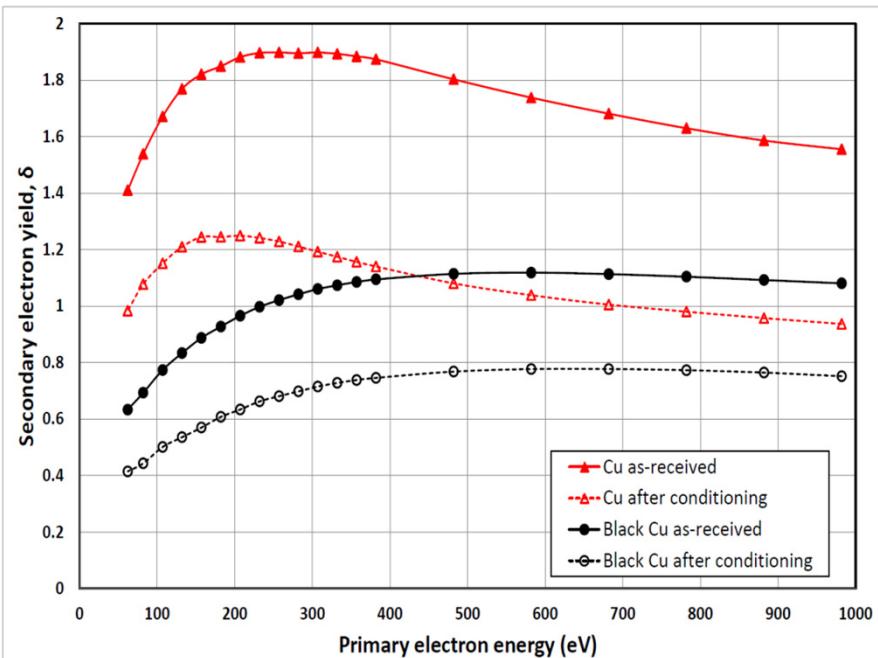


Analysis chamber with

- XPS,
- Flood e-gun,
- Sample heater,
- Ar ion beam.

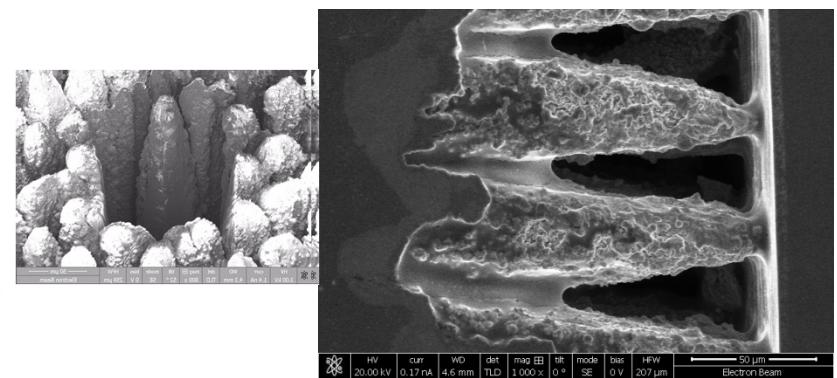


SEY of Cu as a function of incident electron energy



Untreated

Laser treated

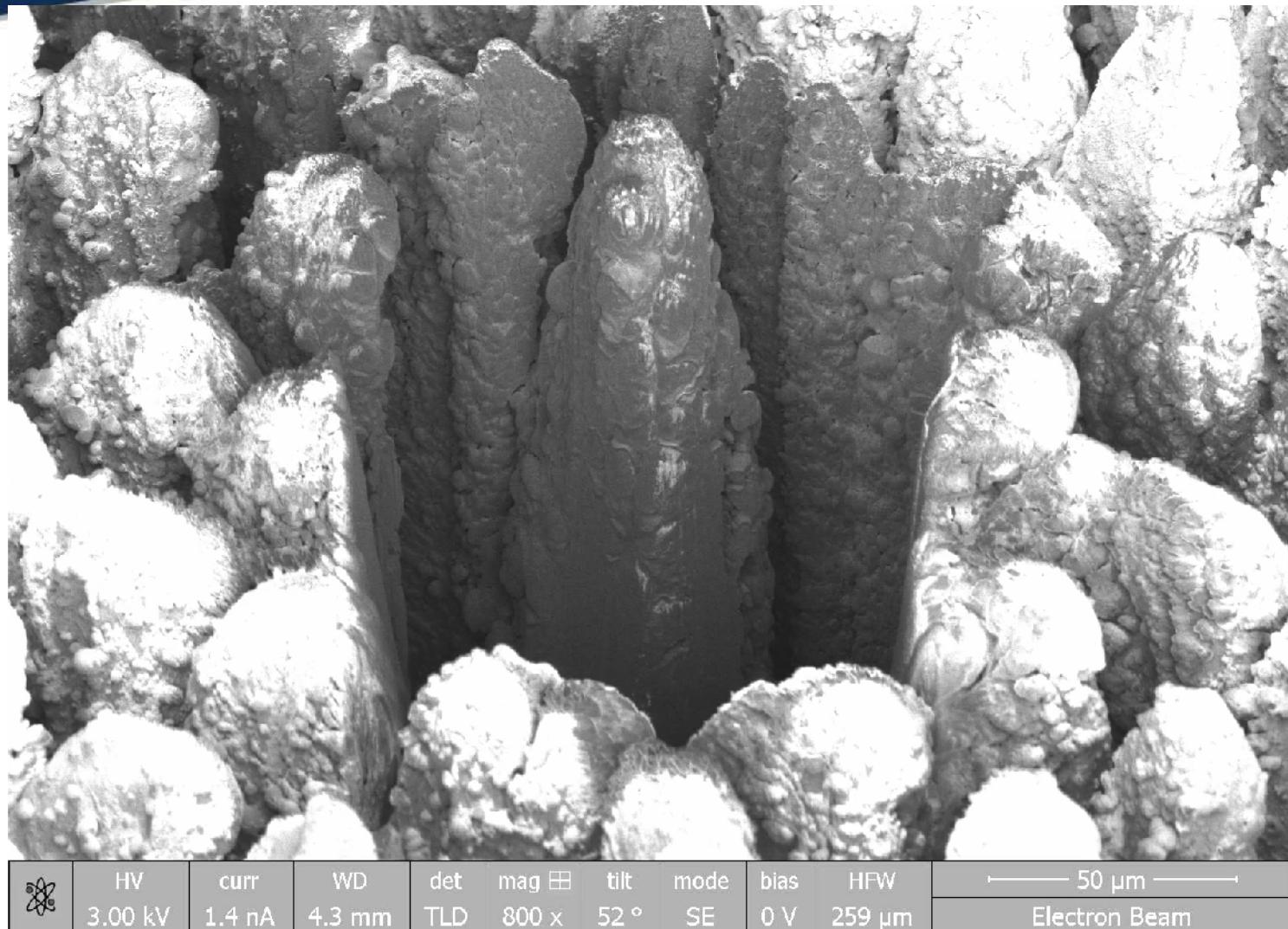


For Copper

Nd:YVO₄ Laser

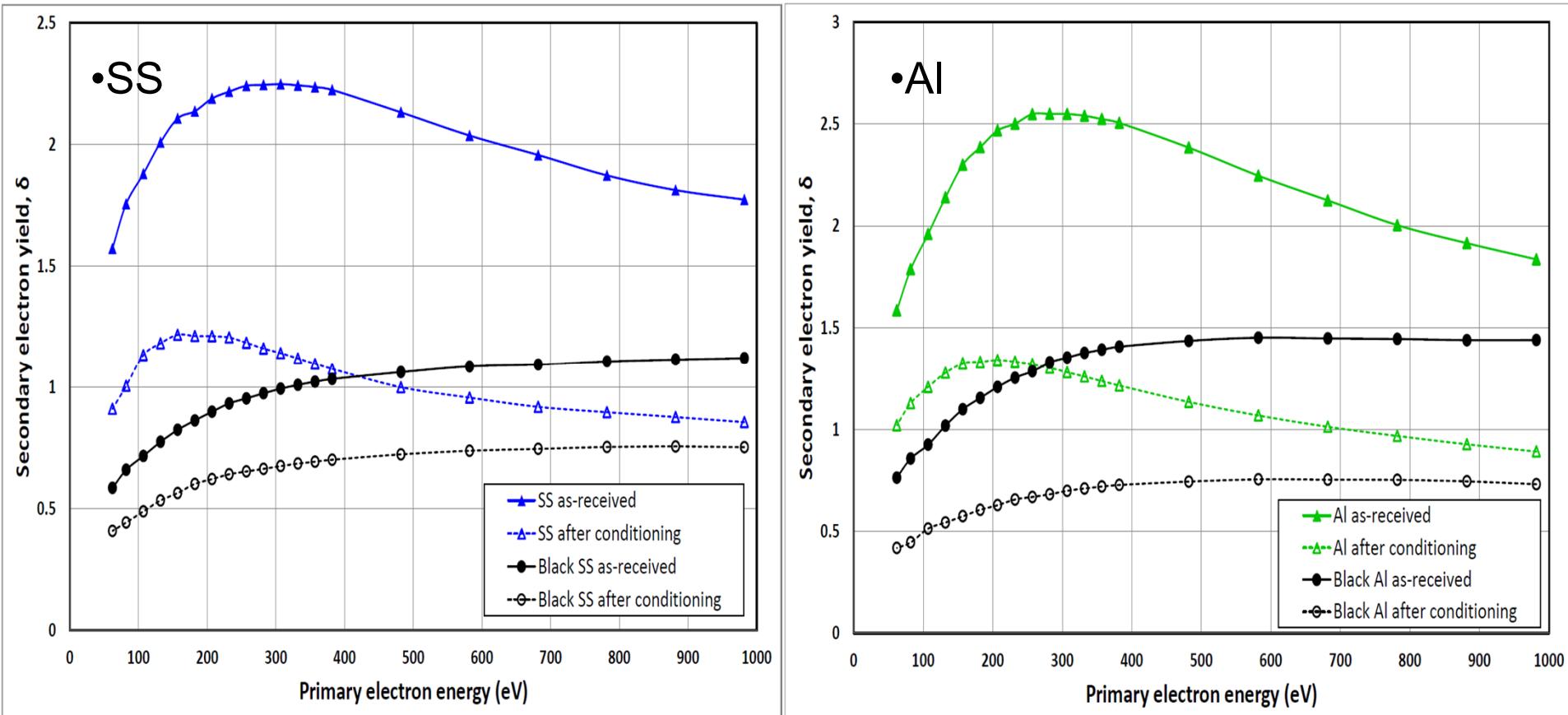
- Max Average Power = 10 W at $\lambda = 532$ nm
- Pulse length = 12 ns at Repetition Rate = 30 kHz
- Argon or air atmosphere
- Beam Raster scanned in both horizontal and vertical direction

Original data June 2014
Applied Physics Letters 12/2014; 105(23): 231605



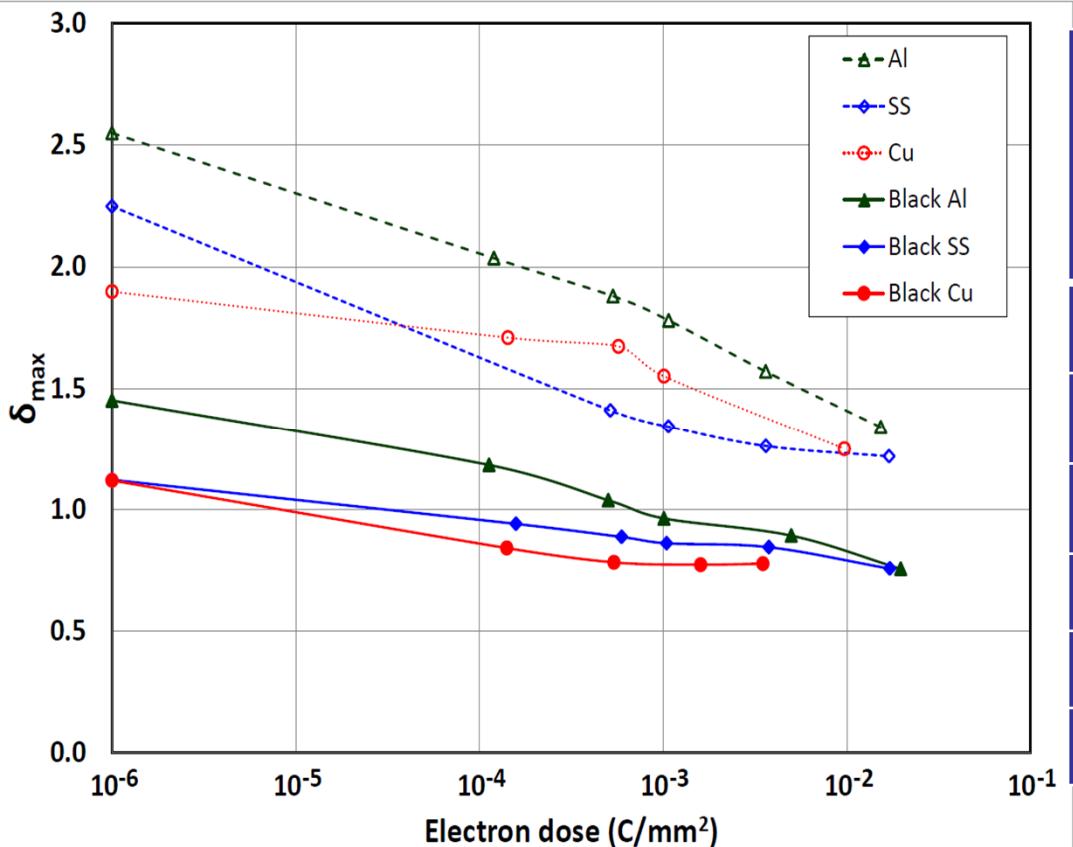
7th International particle Accelerator Conference
Bexco Busan, Korea (IPAC16)

SEY of SS and Al as a function of incident electron energy



Original data June 2014
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δ_{\max} as a function of electron dose for Al, 306L SS and Cu



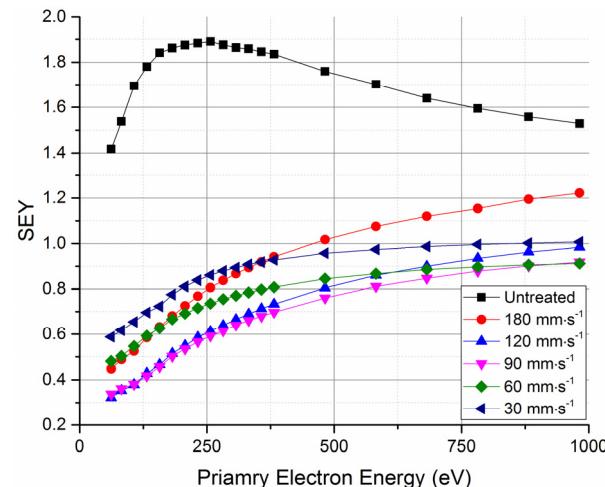
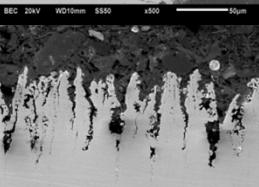
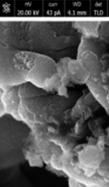
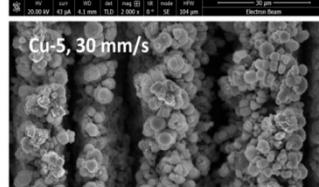
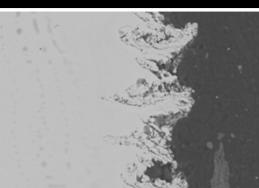
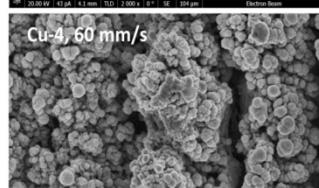
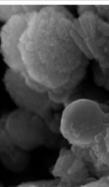
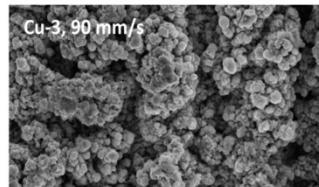
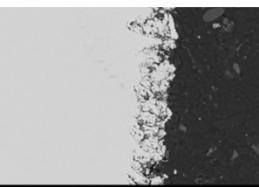
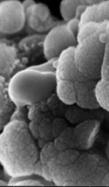
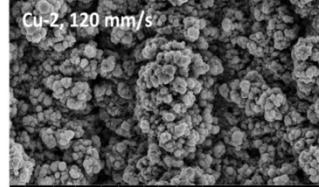
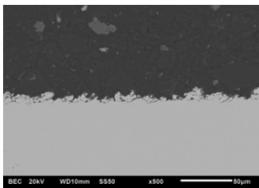
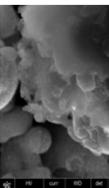
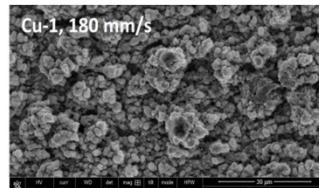
Sample	Initial		After conditioning to Q_{\max}		
	δ_{\max}	E_{\max} (eV)	δ_{\max}	E_{\max} (eV)	Q_{\max} ($C \cdot mm^{-2}$)
Black Cu	1.12	600	0.78	600	3.5×10^{-3}
Black SS	1.12	900	0.76	900	1.7×10^{-2}
Black Al	1.45	900	0.76	600	2.0×10^{-2}
Cu	1.90	300	1.25	200	1.0×10^{-2}
SS	2.25	300	1.22	200	1.7×10^{-2}
Al	2.55	300	1.34	200	1.5×10^{-2}

Reduction of δ_{\max} after conditioning is attributed to change in surface chemistry due to electron-beam induced transformation of CuO to sub-stoichiometric oxide, and build-up of a thin graphite C-C bonding layer on the surface.

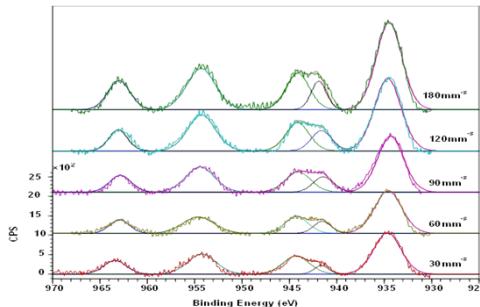


Effect of scan speed

Laser treatment condition	λ (nm)	Average power (W)	Spot size (μm)	Pulse duration (ns)	Pulse repetition (kHz)	Pitch width (μm)	Scan speed (mm/s)	Energy per pulse (μJ)	pulse	Fluence (J/cm^2)
1	355	3	15	25	40	10	30,60,90, 120, 180	75		42



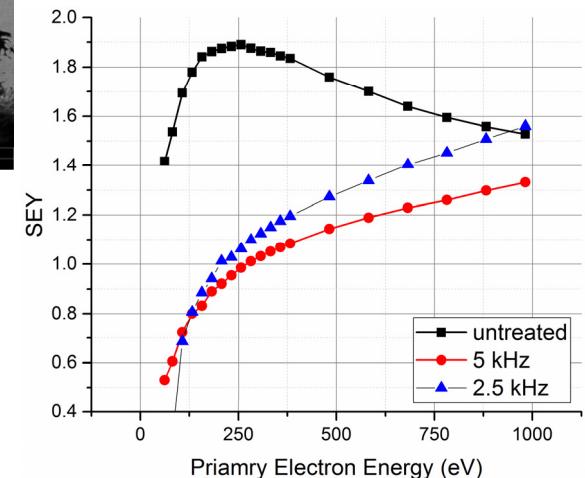
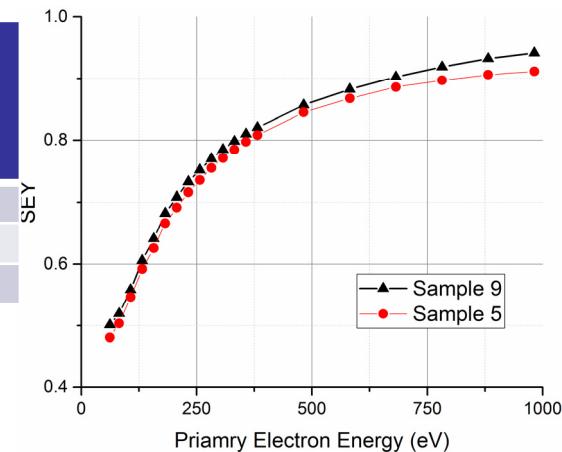
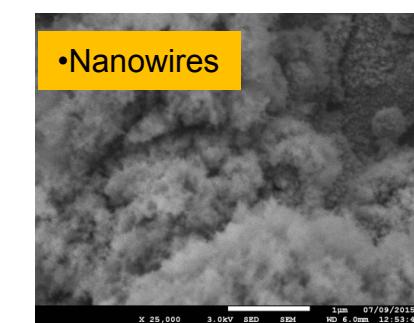
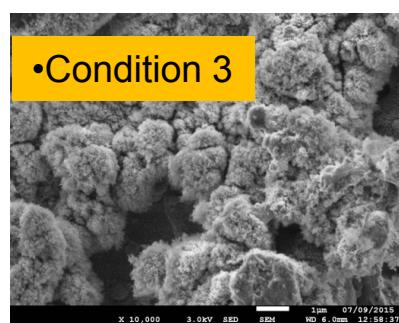
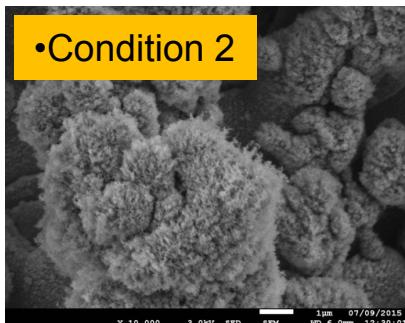
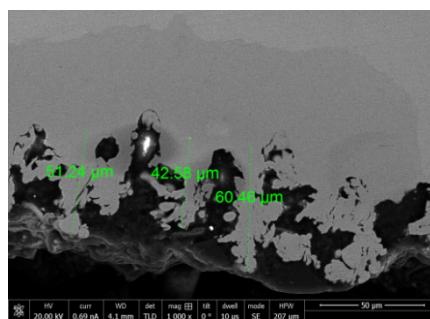
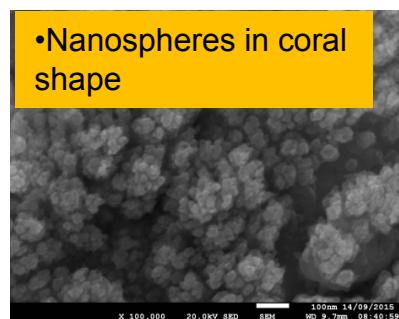
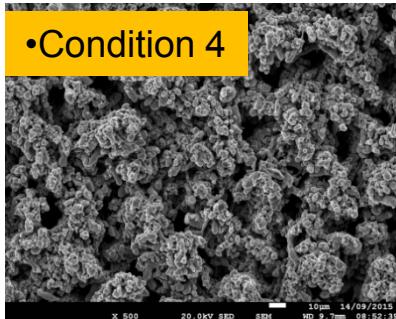
Sample	6	5	4	3	2
Scan speed (mm/s)	30	60	90	120	180
Groove depth (μm)	100	60	35	20	8
δ at $E_p = 60 \text{ eV}$	0.6	0.5	0.3	0.3	0.4
δ at $E_p = 1000 \text{ eV}$	1.0	0.91	0.9	0.98	1.22





Effect of power and repetition rate

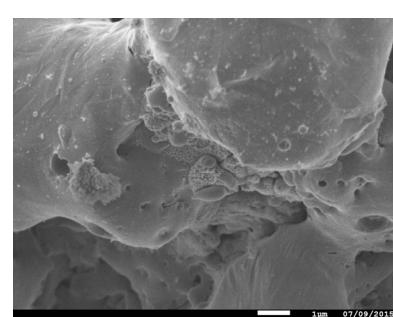
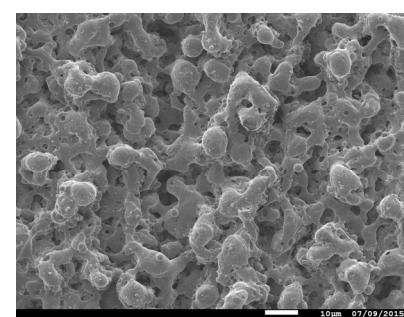
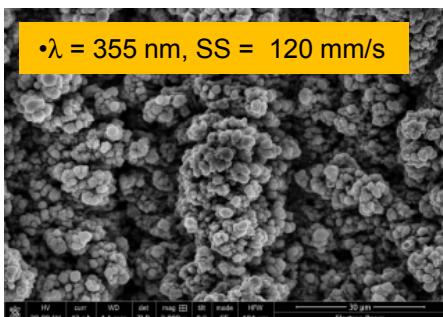
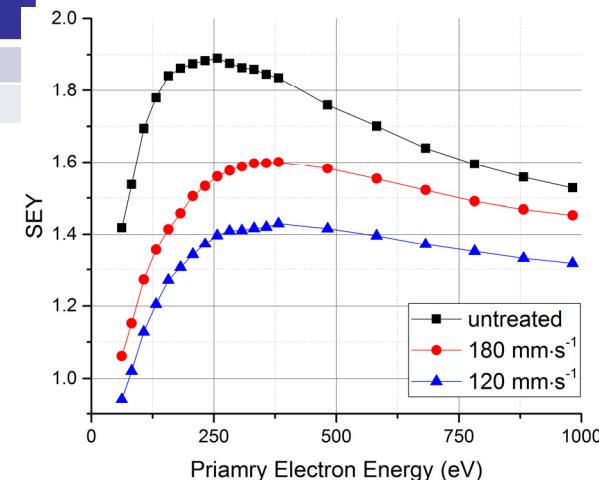
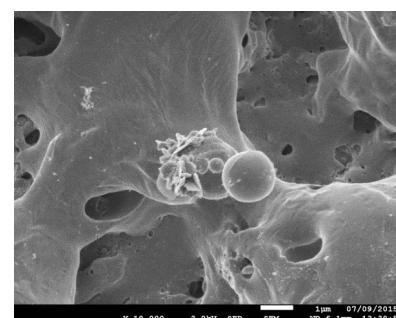
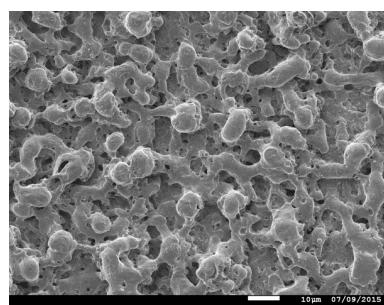
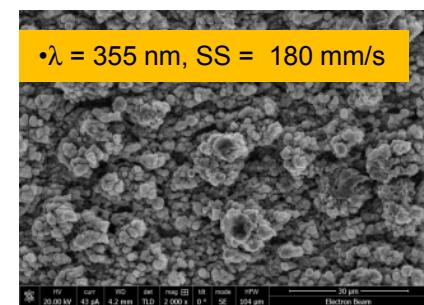
Laser treatment condition	λ (nm)	Average power (W)	Spot size (μm)	Pulse duration (ns)	Pulse repetition (kHz)	Pitch width (μm)	Scan speed (mm/s)	Energy per pulse (μJ)	Fluence (J/cm^2)
2	1064	1.9	25	70	2.5	20	125	760	154
3	1064	2.4	25	70	5.0	20	125	480	97
4	1064	3.6	25	70	10	20	30	360	73





Importance of nano structure

Laser treatment condition	λ (nm)	Average power (W)	Spot size (μm)	Pulse duration (ns)	Pulse repetition (kHz)	Pitch width (μm)	Scan speed (mm/s)	Energy per pulse (μJ)	Fluence (J/cm^2)
5	1064	3	25	70	20	10	500	150	30
6	1064	1	25	70	100	10	500	10	2



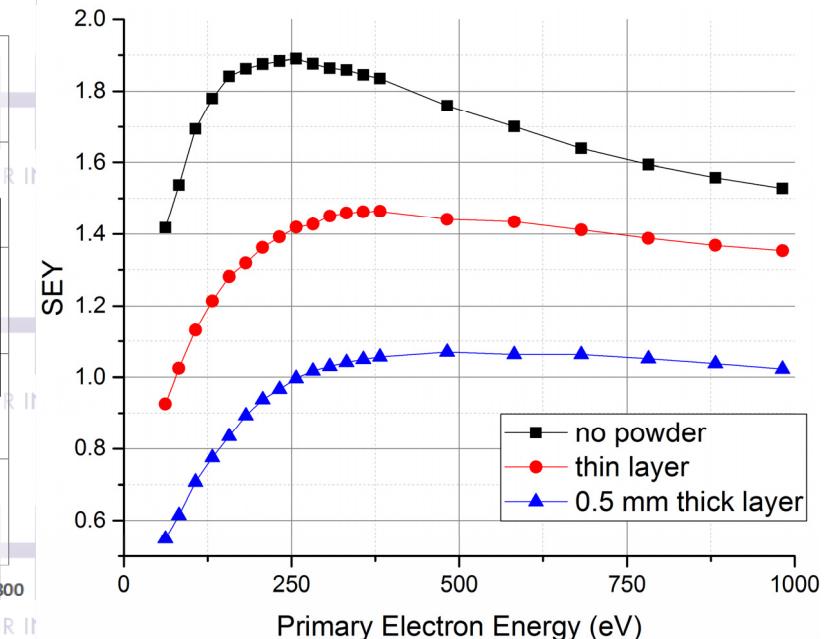
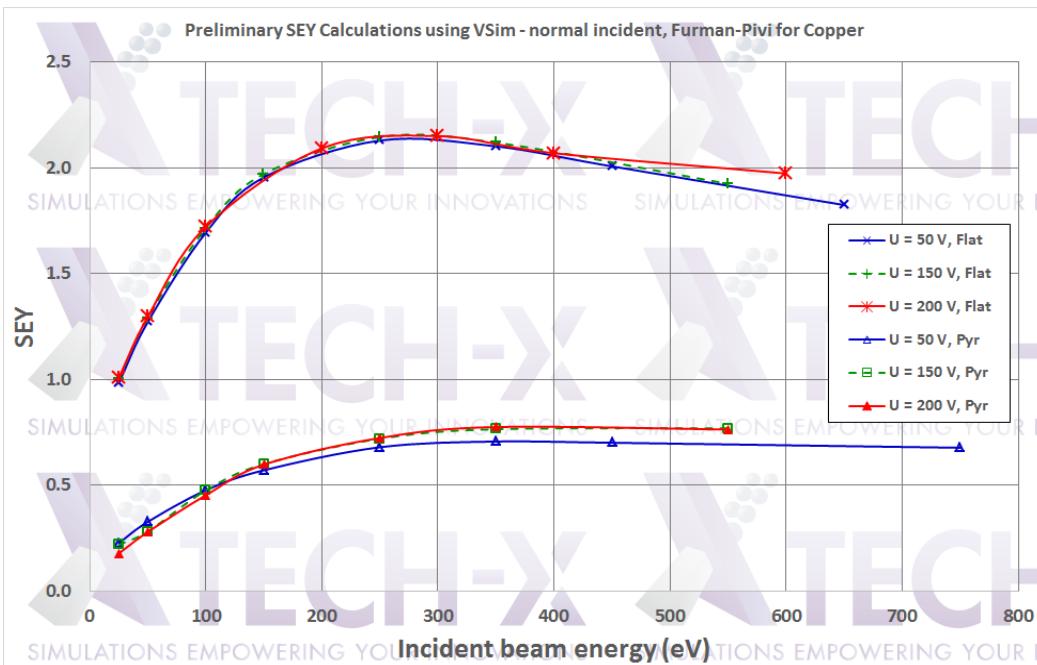
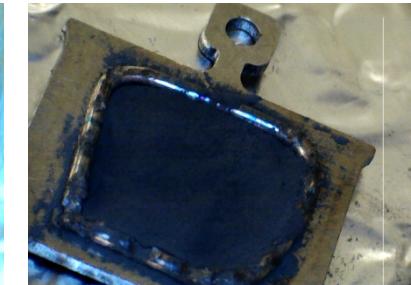
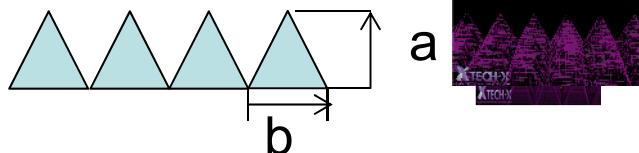
- No visible Nanostructure (due to re-melt)
- SEY resemble to untreated sample

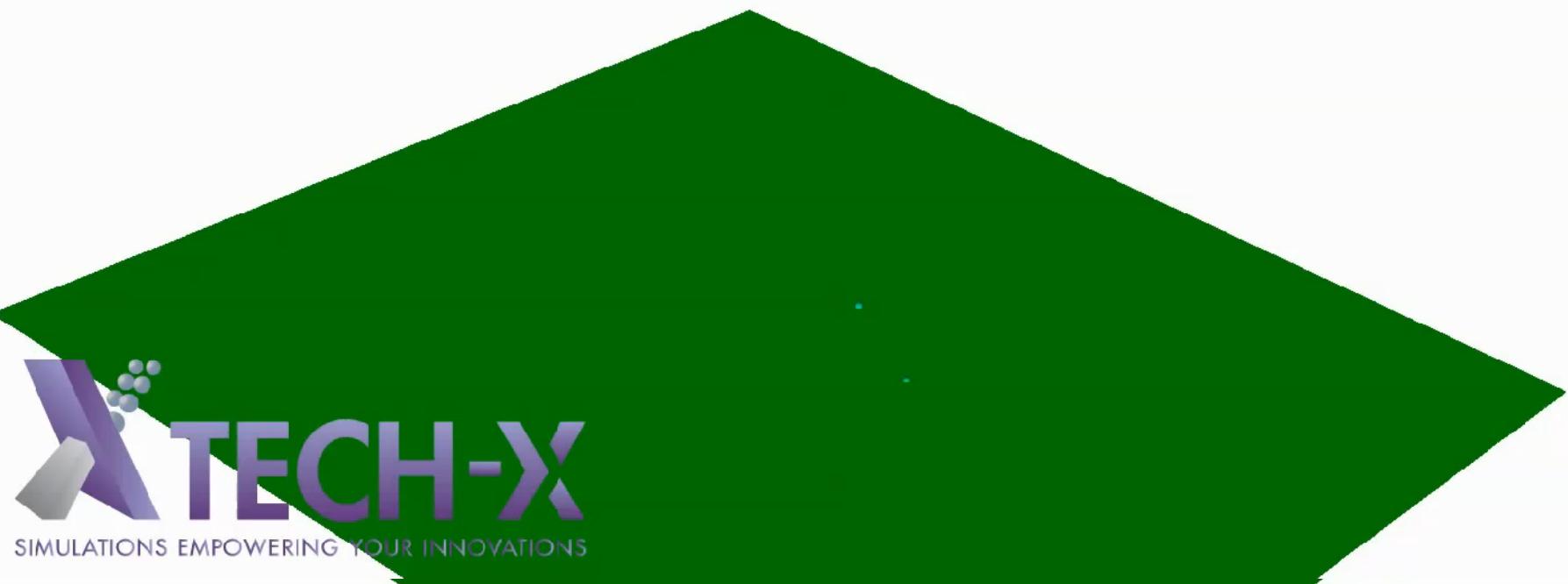


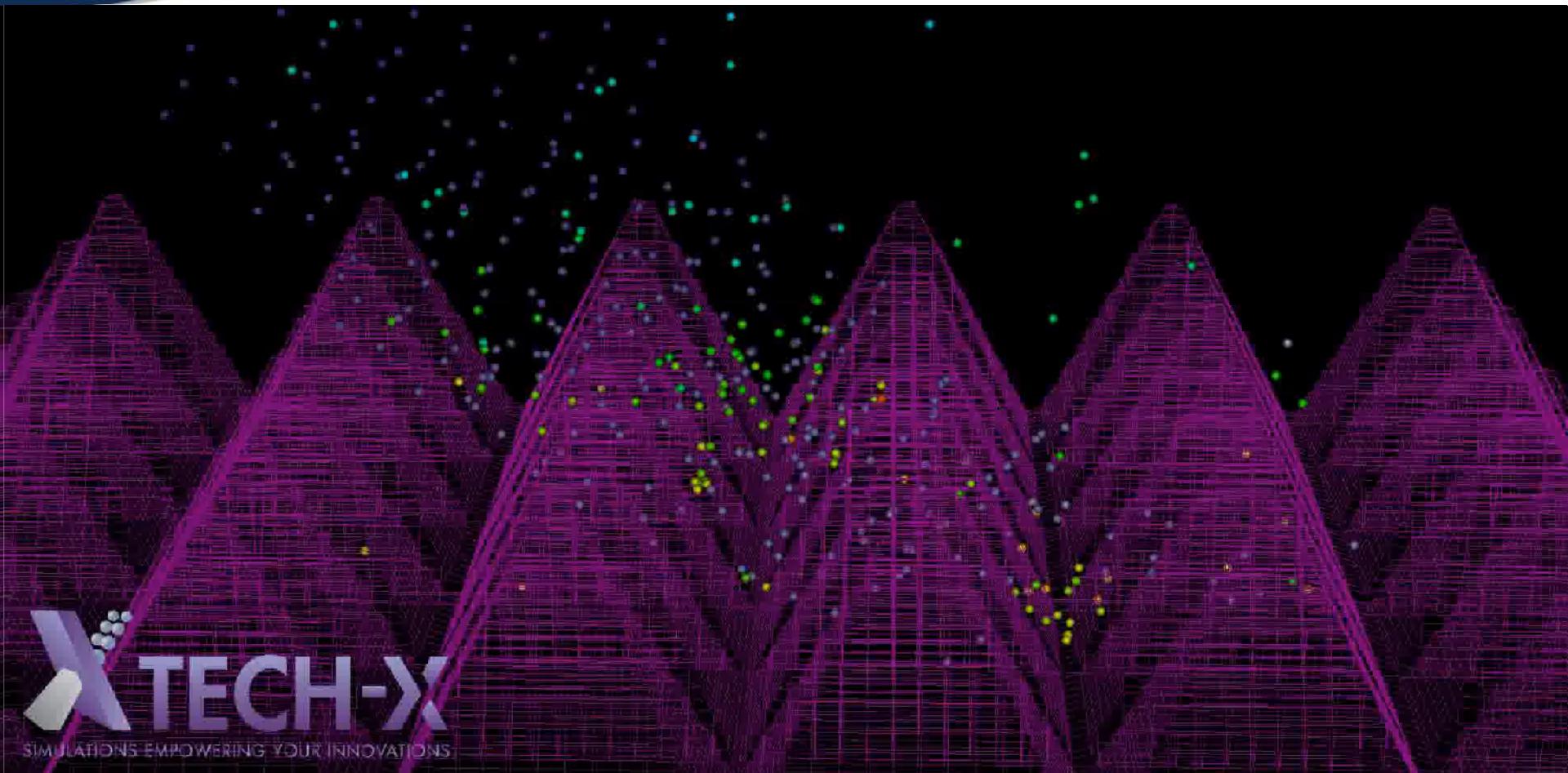
Validation of nano structure and grooves

Flat surface was compared to
Pyramidal structure with high-to-base ratio
 $a/b = 1$

for $\alpha_0 = 90^\circ$



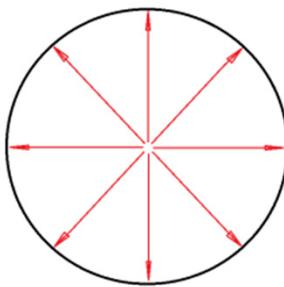
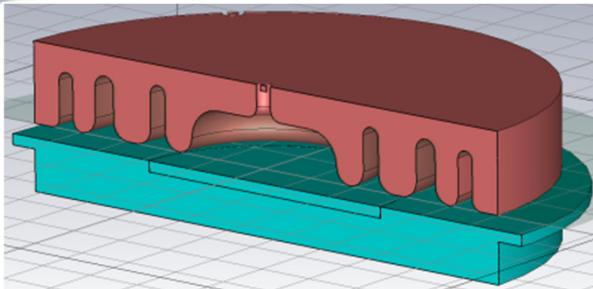




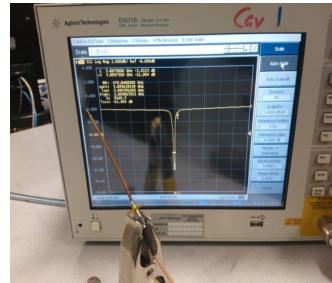
7th International particle Accelerator Conference
Bexco Busan, Korea (IPAC16)



Surface resistance measurements



Sample	Cavity	Measurement	$R_s [\Omega]$
Cu-1L	1	average	7.8×10^{-2}
	2	0°	0.11
	2	45°	0.11
	2	90°	9.5×10^{-2}
Cu-2L	1	average	0.13
Cu-3L	1	average	0.14
	2	0°	0.15
	2	45°	0.19
	2	90°	0.2
Cu untreated	1	average	3.3×10^{-2}
Al untreated	1	average	7.2×10^{-2}
SS untreated	1	average	0.17

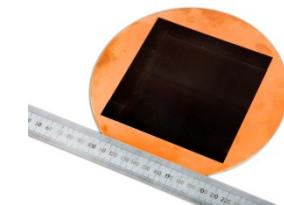
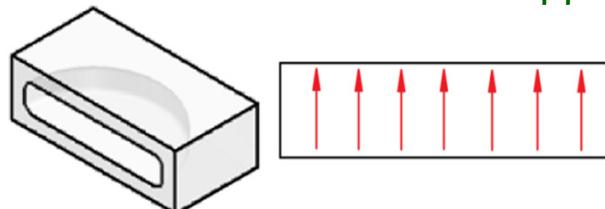


Test cavities (3.9 and 7.8 GHz):

- The simulation results obtained with Microwave Studio
- Fabricated from Al.
- 3 choke cavity operating in TM_{010} mode, has circular H field distribution hence induces radial current.
- Half pill box cavity operating in TM_{110} mode, has strong transverse H field hence induces axial electric current

Samples:

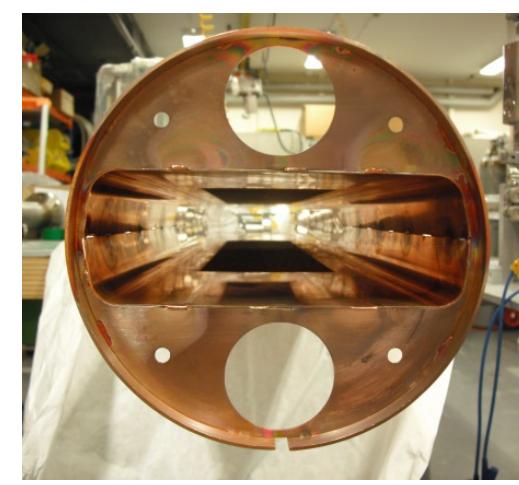
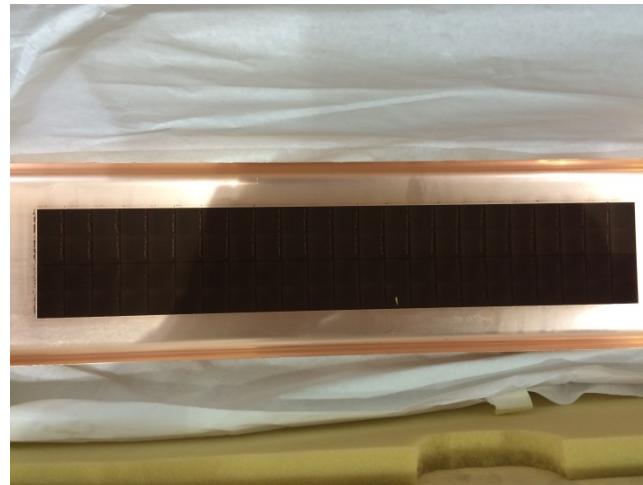
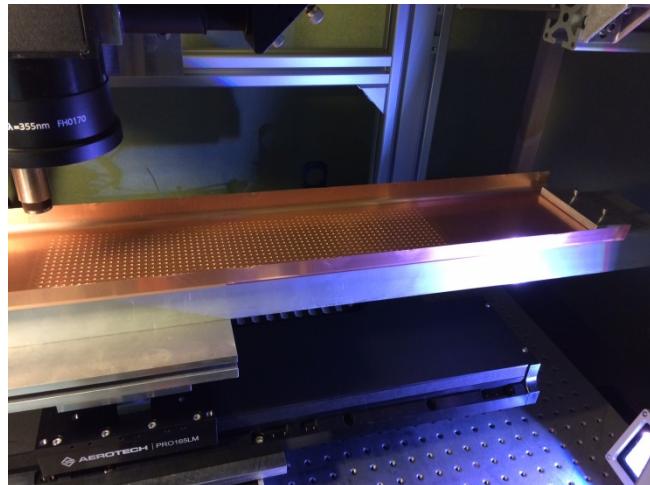
- 3 of 100-mm² laser treated copper surface



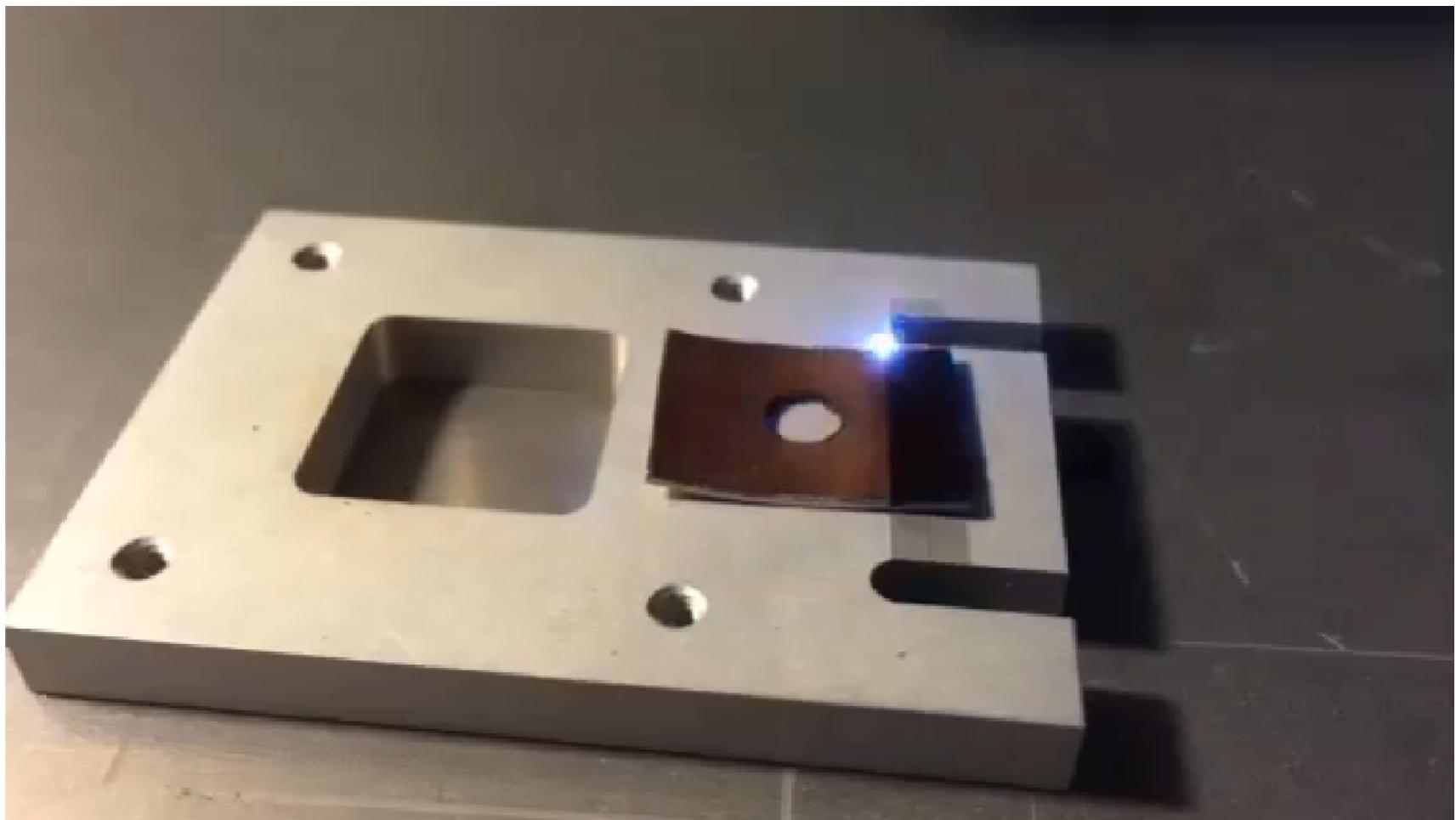


Large scale test in SPS at CERN

Laser treatment condition	λ (nm)	Average power (W)	Spot size (μm)	Pulse duration (ns)	Pulse repetition (kHz)	Pitch width (μm)	Scan speed (mm/s)	Energy per pulse (μJ)	Fluence (J/cm^2)
1	355	3	15	25	40	10	90, 120,	75	42



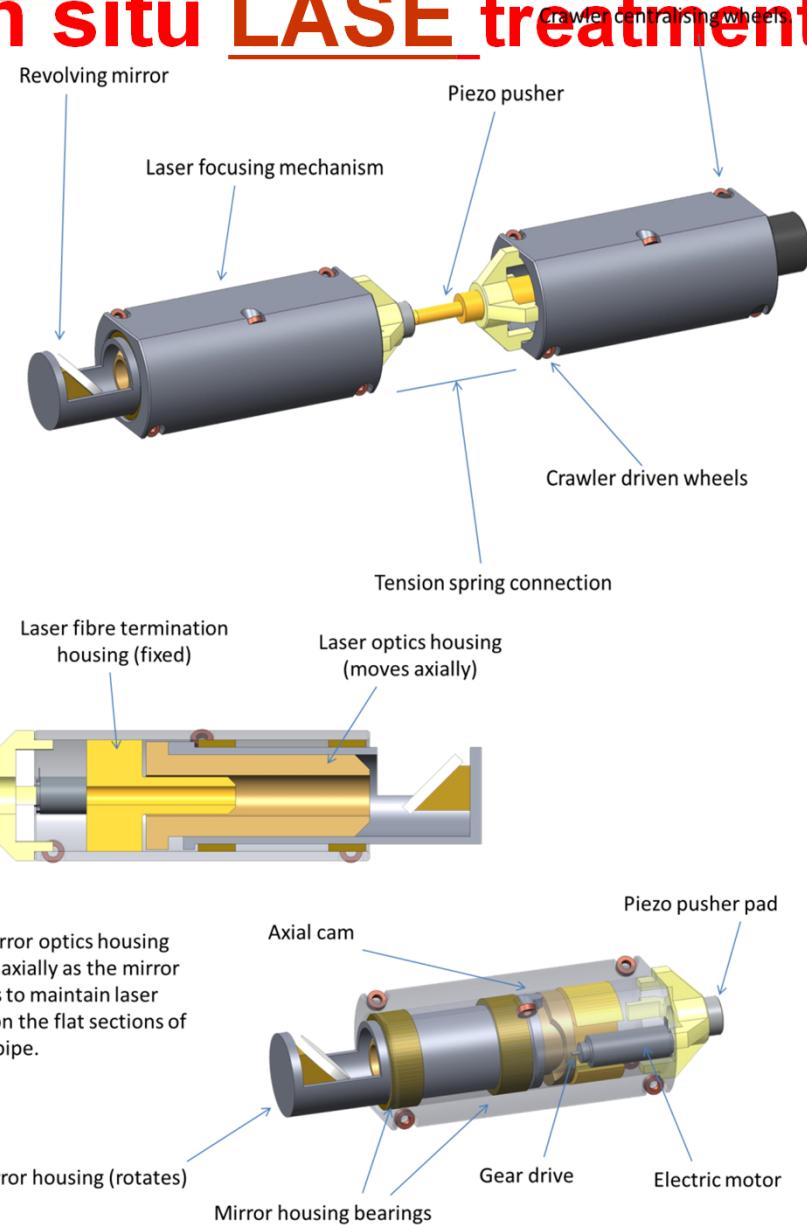
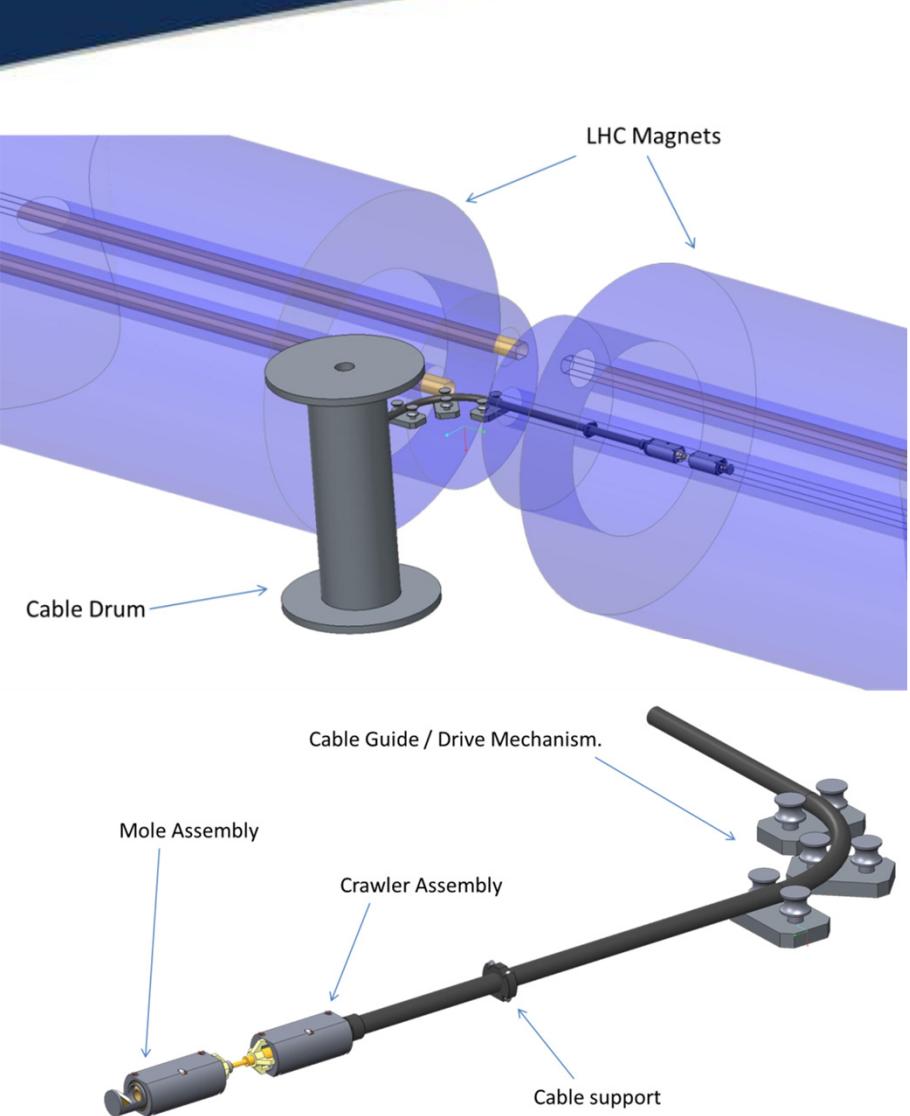
- SPS liner as test sample has been laser treated
- Two areas of $40 \times 490 \text{ mm}^2$ was treated with conditions above



The international workshop on Functional Surface
Coatings and Treatment



Future technology for in situ LASE treatment





Summary: LASE properties

- **SEY:**
- **Surface resistance with LASE can increase**



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- **SEY:**

- **LASE** on a metal surface is a very viable solution for reducing the $\delta < 1$.
- **SEY** is reduced by a combination of two geometrical effects

- **Surface resistance with LASE can increase**



Summary: LASE properties

- **SEY:**

- **LASE** on a metal surface is a very viable solution for reducing the $\delta < 1$.
- **SEY** is reduced by a combination of two geometrical effects
 1. **Due to the grooves** which traps the electrons by multiple side wall collision (confirmed by measurements and modelling) and
 2. **The nano-sphere** which are superimposed on top of the walls of the groove (confirmed by measurements of metal powder and remelting of the nano sphere)
 3. **A further reduction** can be achieved by the surface chemistry change during a bakeout and/or bombardment with electrons, ions and (very likely) photons .

- **Surface resistance with LASE can increase**



Summary: LASE properties

- **SEY:**

- **LASE** on a metal surface is a very viable solution for reducing the $\delta < 1$.
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- **Surface resistance with LASE can increase**

- measured values of surface resistance at 3.9 and 7.8 GHz shows that **shallow groove** type with **superimposed nano-sphere** is a preferable solution to minimise the surface impedance in accelerator beam pipe.

The main conclusion

- LASE can be a key solution for the e-cloud suppression in high energy particle accelerators:
 - $\delta < 1$
 - Insignificant to moderate increase in impedance
 - Easy implementation
 - Robust
 - Highly reproducible
 - Inexpensive
 - In-situ